



ACE4444B

N-Channel Enhancement Mode Field Effect Transistor

Description

The ACE4444B uses advanced trench technology to provide excellent $R_{DS(ON)}$ and low gate charge. This device is suitable for use as a load switch or in PWM applications. The source leads are separated to allow a Kelvin connection to the source, which may be used to bypass the source inductance.

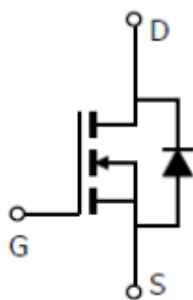
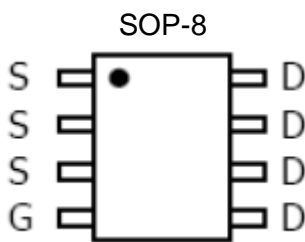
Features

- $V_{DS}(V)=30V$
- $I_D=20A$ ($V_{GS}=10V$)
- $R_{DS(ON)} < 5.5m\Omega$ ($V_{GS}=10V$)
- $R_{DS(ON)} < 8.5m\Omega$ ($V_{GS}=4.5V$)

Absolute Maximum Ratings

Parameter		Symbol	Max	Unit
Drain-Source Voltage		V_{DSS}	30	V
Gate-Source Voltage		V_{GSS}	± 20	V
Drain Current (Continuous) *AC	$T_A=25^\circ C$	I_D	20	A
	$T_A=70^\circ C$		17	
Drain Current (Pulse) *B		I_{DM}	80	
Power Dissipation	$T_A=25^\circ C$	P_D	3	W
	$T_A=70^\circ C$		2.1	
Operating and Storage Temperature Range		T_J, T_{STG}	-55 to 150	$^\circ C$

Packaging Type



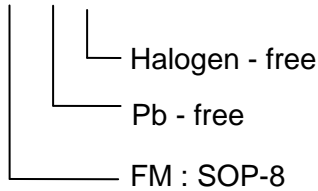


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Ordering information

ACE4444B XX + H



Electrical Characteristics $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} =0V, I _D =250uA	30			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =24V, V _{GS} =0V			1	uA
Gate Leakage Current	I _{GSS}	V _{GS} =±20V, V _{DS} =0V			100	nA
Static Drain-Source On-Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =20A		5.1	5.5	mΩ
		V _{GS} =4.5V, I _D =15A		7.4	8.5	
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _{DS} =250uA	1	1.8	3	V
Forward Transconductance	g _{FS}	V _{DS} =5V, I _D =20A		100		S
Diode Forward Voltage	V _{SD}	I _{SD} =1A, V _{GS} =0V		0.76	1.0	V
Maximum Body-Diode Continuous Current	I _S				4	A
Switching						
Total Gate Charge	Q _g	V _{DS} =15V, I _D =20A V _{GS} =4.5V		28.5	37	nC
Gate-Source Charge	Q _{gs}			8.1	10.5	
Gate-Drain Charge	Q _{gd}			12	15.6	
Turn-On Delay Time	T _{d(on)}	V _{DS} =15V, V _{GS} =10V R _{GEN} =3Ω, R _L =0.75Ω		19	38	ns
Turn-On Rise Time	t _f			9.44	18.88	
Turn-Off Delay Time	t _{d(off)}			58.84	117.68	
Turn-Off Fall Time	t _f			8.68	17.36	
Dynamic						
Input Capacitance	C _{iss}	V _{DS} =15V, V _{GS} =0V f=1MHz		3234.38		pF
Output Capacitance	C _{oss}			456.44		
Reverse Transfer Capacitance	C _{rss}			329.12		

Note: A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The value in any given application depends on the user's specific board design.

B. Repetitive rating, pulse width limited by junction temperature.

C. The current rating is based on the $t \leq 10s$ junction to ambient thermal resistance rating.



Typical Performance Characteristics

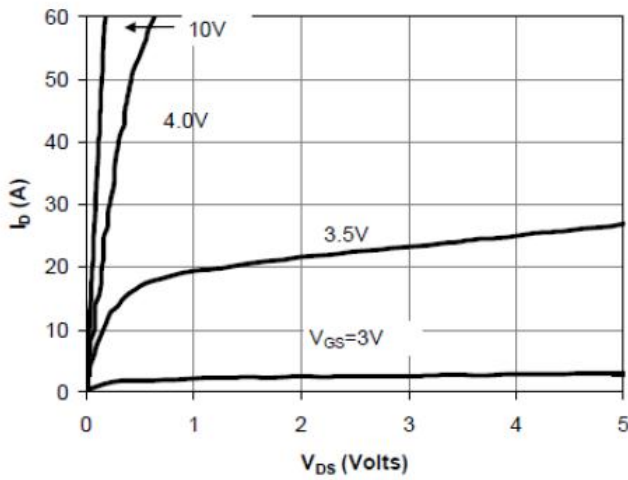


Fig 1: On-Region Characteristics

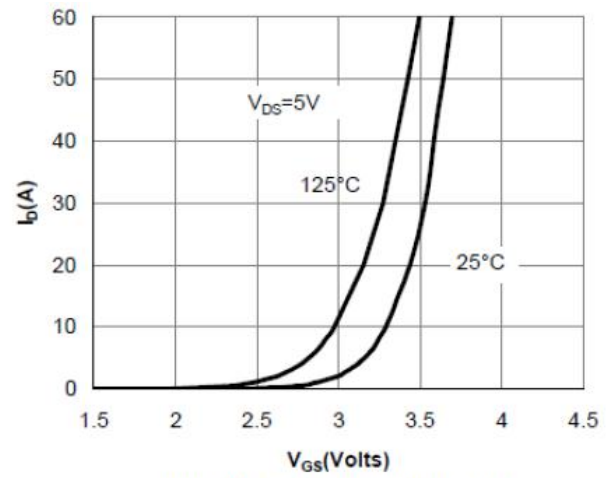


Figure 2: Transfer Characteristics

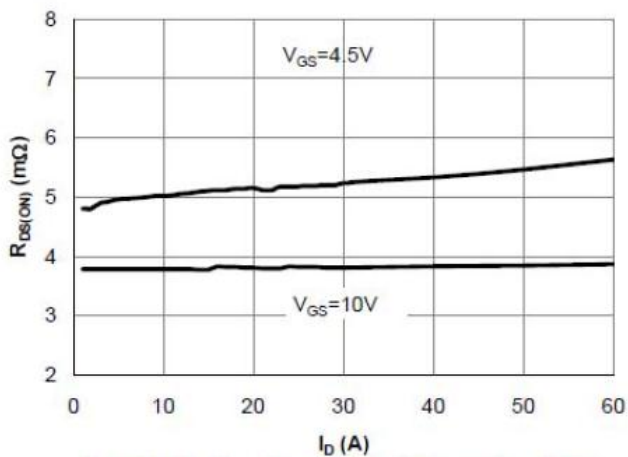


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

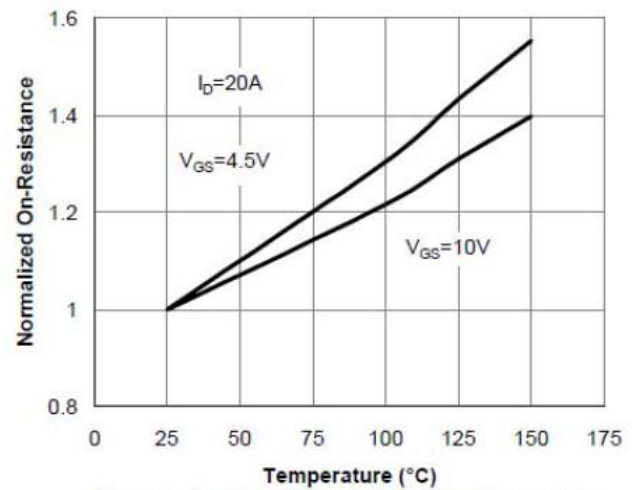


Figure 4: On-Resistance vs. Junction Temperature

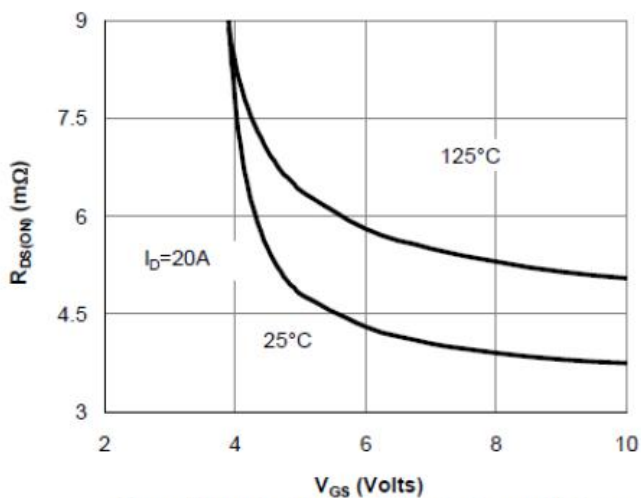


Figure 5: On-Resistance vs. Gate-Source Voltage

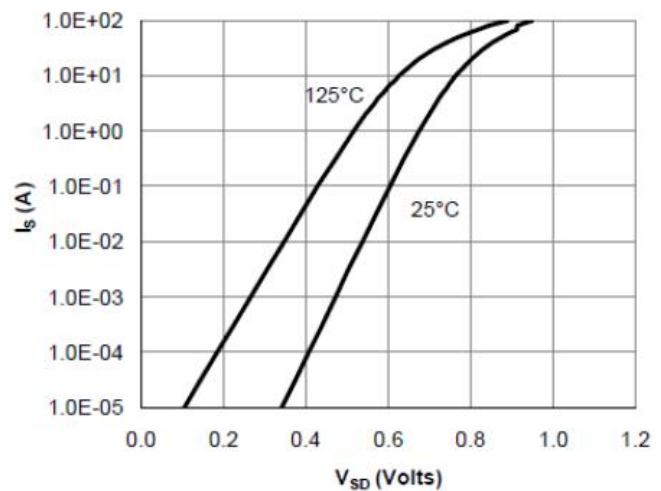


Figure 6: Body-Diode Characteristics



Typical Performance Characteristics

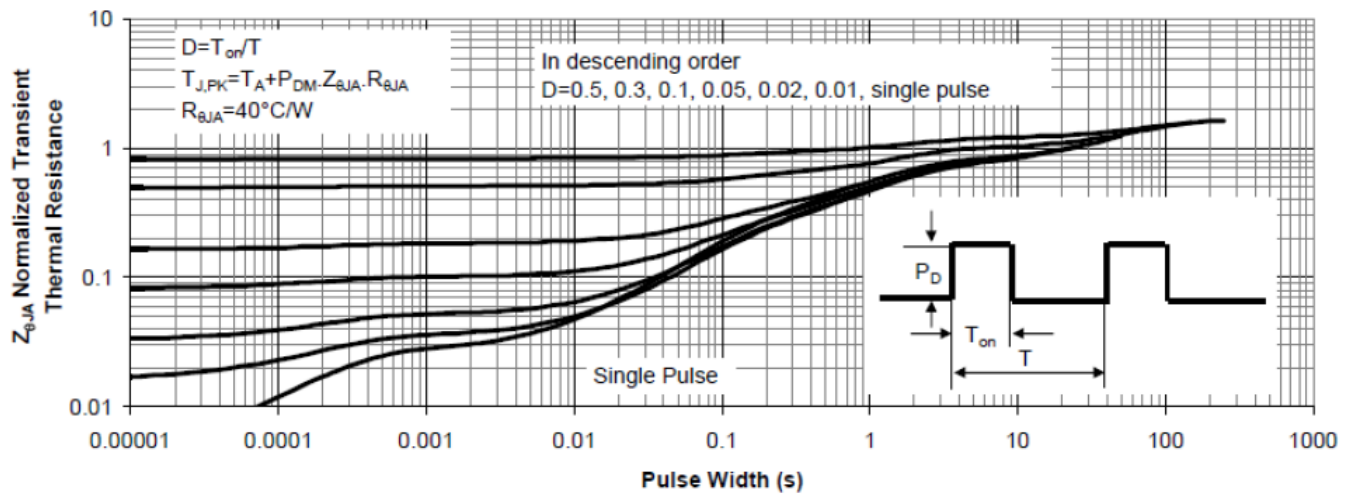


Figure 7 : Normalized Maximum Transient Thermal Impedance

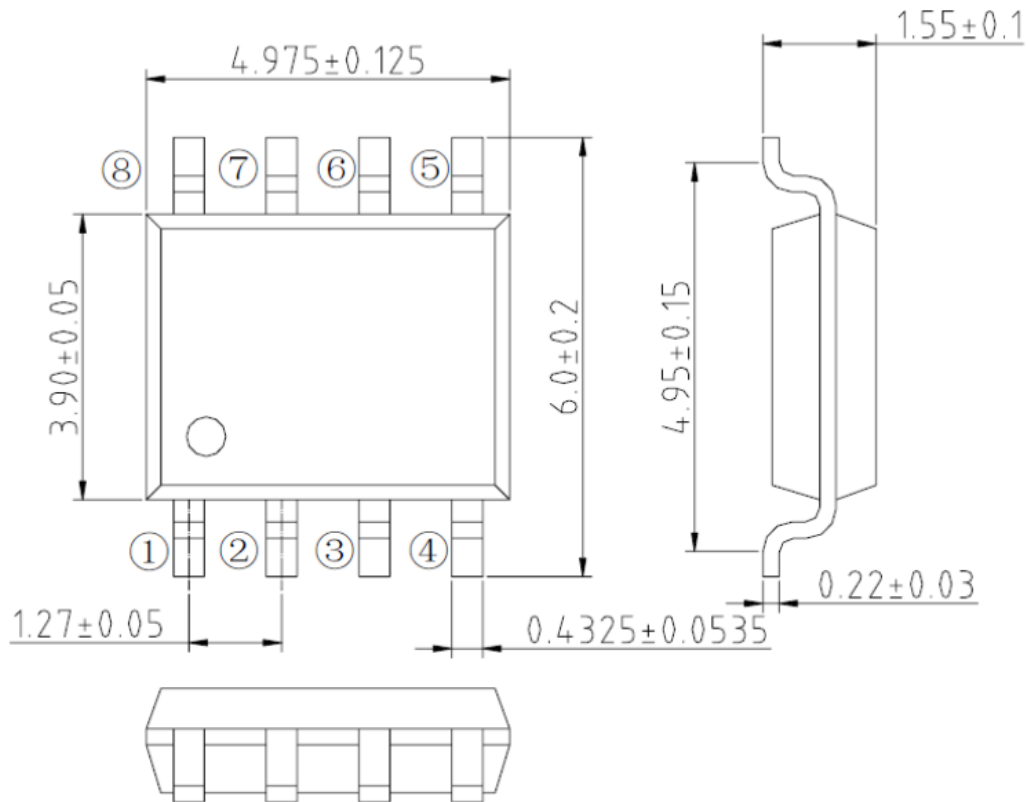


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Packing Information

SOP-8



Unit: mm



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Notes

ACE does not assume any responsibility for use as critical components in life support devices or systems without the express written approval of the president and general counsel of ACE Electronics Co., LTD. As sued herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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